Notice of References Cited Application/Control No. 10/710,950 Examiner VAN T. PHAM Applicant(s)/Patent Under Reexamination LAI ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,229,773	05-2001	Chou, Wen-Te	369/44.28
*	В	US-6,167,011	12-2000	Sun et al.	369/44.41
*	С	US-6,317,399	11-2001	Ohtani et al.	369/47.44
*	D	US-6,469,962	10-2002	Chu, Meng-Huang	369/44.28
*	Е	US-2004/0136282	07-2004	Chen, Chih-Yuan	369/044.35
	F	US-			
·	G	US-			
	Н	US-			
	l	US-			
	J	US-			·
	K	US-		·	
	L	US-	·		
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
•	0					
	Р				•	·
	Q					
	R				•	
	S	•				•
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U			•		
	V					
	w		•			
	X					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.